

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/601,573	LEE, SEUNG-JAE	
		Examiner	Art Unit	Page 1 of 1
		Dan Colilla	2854	

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0171727	11-2002	Kida et al.	347/104
	B	US-6,457,888	10-2002	Matsumoto, Toshiya	400/625
	C	US-2002/0089564	07-2002	Ohashi, Tetsuyo	347/41
	D	US-6,089,773	07-2000	Bailey et al.	400/642
	E	US-5,775,824	07-1998	Bae, Sang-Jin	400/636
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2003072111 A	03-2003	Japan	SHIKAME, YUJI	B41J 02/18
	O	JP 2002103706 A	04-2002	Japan	KANEMITSU, MASATOMO	B41J 11/02
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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